DMP26M1UPS
20V P-CHANNEL ENHANCEMENT MODE MOSFET
PowerDI5060-8

## Product Summary

| BV ${ }_{\text {dss }}$ | RDS(ON) MAX | $\begin{gathered} \mathrm{I}_{\mathrm{D}}^{\operatorname{MAX}} \\ \mathrm{T}_{\mathrm{C}}=+25^{\circ} \mathrm{C} \end{gathered}$ |
| :---: | :---: | :---: |
| -20V | $6 \mathrm{~m} \Omega$ @ $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}$ | -90A |
|  | $8 \mathrm{~m} \Omega$ @ $\mathrm{V}_{\mathrm{GS}}=-2.5 \mathrm{~V}$ | -78A |

## Description

This new generation MOSFET is designed to minimize $\mathrm{R}_{\mathrm{DS}(\mathrm{ON})}$ and yet maintain superior switching performance. This device is ideal for use in Notebook battery power management and load switch.

## Applications

- Load Switch
- Power Management Functions


## Features

- Thermally Efficient Package-Cooler Running Applications
- High Conversion Efficiency
- Low $R_{\text {DS(ON) }}$ - Minimizes On State Losses
- 100\% Unclamped Inductive Switching (UIS) Test in Production Ensures More Reliable and Robust End Application
- $\quad<1.1 \mathrm{~mm}$ Package Profile - Ideal for Thin Applications
- Lead-Free Finish; RoHS Compliant (Notes 1 \& 2)
- Halogen- and Antimony-Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/quality/product-definitions/


## Mechanical Data

- Case: PowerDI ${ }^{\circledR}$ 5060-8
- Case Material: Molded Plastic, "Green" Molding Compound; UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Finish - Matte Tin Annealed over Copper Lead-frame; Solderable per MIL-STD-202, Method 208 e3)
- Weight: 0.097 grams (Approximate)


Internal Schematic


## Ordering Information (Note 4)

| Part Number | Case | Packaging |
| :---: | :---: | :---: |
| DMP26M1UPS-13 | PowerDI5060-8 | $2,500 /$ Tape \& Reel |

Notes: 1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) \& 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
3. Halogen- and Antimony-free "Green" products are defined as those which contain $<900 \mathrm{ppm}$ bromine, $<900 \mathrm{ppm}$ chlorine ( $<1500 \mathrm{ppm}$ total $\mathrm{Br}+\mathrm{Cl}$ ) and <1000ppm antimony compounds.
4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## Marking Information



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Maximum Ratings ( $@ T_{A}=+25^{\circ} \mathrm{C}$, unless otherwise specified.)

| Characteristic |  | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Drain-Source Voltage |  | V ${ }_{\text {DSS }}$ | -20 | V |
| Gate-Source Voltage |  | $\mathrm{V}_{\text {GSS }}$ | $\pm 10$ | V |
| Continuous Drain Current, $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ (Note 7) | $\mathrm{T}_{\mathrm{C}}=+25^{\circ} \mathrm{C}$ | ID | -90 | A |
|  | $\mathrm{T}_{\mathrm{C}}=+70^{\circ} \mathrm{C}$ |  | -72 |  |
| Pulsed Drain Current (10 $\mu$ s Pulse, Duty Cycle = 1\%) |  | IDM | -360 | A |
| Maximum Continuous Body Diode Forward Current (Note 6) |  | Is | -4.5 | A |
| Pulsed Body Diode Forward Current (10 $\mu$ s Pulse, Duty Cycle = 1\%) |  | ISM | -360 | A |
| Avalanche Current, L $=0.1 \mathrm{mH}$ (Note 8) |  | $\mathrm{I}_{\text {AS }}$ | -30 | A |
| Avalanche Energy, L $=0.1 \mathrm{mH}$ (Note 8) |  | $E_{\text {AS }}$ | 47 | mJ |

## Thermal Characteristics

| Characteristic |  |  |  |  |  |  |  | Symbol | Value | Unit |
| :--- | :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Total Power Dissipation (Note 5) | $\mathrm{P}_{\mathrm{D}}$ | 1.34 | W |  |  |  |  |  |  |  |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady State | $\mathrm{R}_{\theta \mathrm{JA}}$ | 93 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |  |  |  |  |  |
| Total Power Dissipation (Note 6) | $\mathrm{P}_{\mathrm{D}}$ | 2.76 | W |  |  |  |  |  |  |  |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady State | $\mathrm{R}_{\theta \mathrm{JA}}$ | 45 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |  |  |  |  |  |
| Thermal Resistance, Junction to Case (Note 7) | $\mathrm{R}_{\theta \mathrm{JC}}$ | 1.7 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |  |  |  |  |  |  |  |
| Operating and Storage Temperature Range | $\mathrm{T}_{J,} \mathrm{~T}_{\text {STG }}$ | -55 to +150 | ${ }^{\circ} \mathrm{C}$ |  |  |  |  |  |  |  |

Electrical Characteristics (@ $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OFF CHARACTERISTICS (Note 9) |  |  |  |  |  |  |
| Drain-Source Breakdown Voltage | BV ${ }_{\text {DSS }}$ | -20 | - | - | V | $\mathrm{V}_{G S}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ |
| Zero Gate Voltage Drain Current | IDSS | - | - | -1 | $\mu \mathrm{A}$ | $V_{\text {DS }}=-16 \mathrm{~V}, \mathrm{~V}_{G S}=0 \mathrm{~V}$ |
| Gate-Source Leakage | Igss | - | - | $\pm 100$ | nA | $\mathrm{V}_{G S}= \pm 8 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=0 \mathrm{~V}$ |
| ON CHARACTERISTICS (Note 9) |  |  |  |  |  |  |
| Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS}}(\mathrm{TH})$ | -0.4 | - | -1 | V | $\mathrm{V}_{\mathrm{DS}}=\mathrm{V}_{\mathrm{GS}}, \mathrm{I}_{\mathrm{D}}=-250 \mu \mathrm{~A}$ |
| Static Drain-Source On-Resistance | R DS (ON) | - | 5 | 6 | $\mathrm{m} \Omega$ | $\mathrm{V}_{G S}=-4.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-15 \mathrm{~A}$ |
|  |  | - | 6.2 | 8 |  | $\mathrm{V}_{\mathrm{GS}}=-2.5 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-10 \mathrm{~A}$ |
| Diode Forward Voltage | $\mathrm{V}_{\text {SD }}$ | - | -0.54 | -1.1 | V | $\mathrm{V}_{G S}=0 \mathrm{~V}, \mathrm{I} \mathrm{I}=-1 \mathrm{~A}$ |
| DYNAMIC CHARACTERISTICS (Note 10) |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | - | 5392 | - | pF | $\begin{aligned} & V_{D S}=-10 V, V_{G S}=0 V \\ & f=1 \mathrm{MHz} \end{aligned}$ |
| Output Capacitance | Coss | - | 608 | - | pF |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ | - | 564 | - | pF |  |
| Gate Resistance | $\mathrm{Rg}_{\mathrm{g}}$ | - | 2.05 | - | $\Omega$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}$ |
| Total Gate Charge ( $\mathrm{V}_{\mathrm{GS}}=-4.5 \mathrm{~V}$ ) | $\mathrm{Q}_{\mathrm{g}}$ | - | 75 | - | nC | $V_{D S}=-10 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=-20 \mathrm{~A}$ |
| Total Gate Charge ( $\mathrm{V}_{\mathrm{GS}}=-10 \mathrm{~V}$ ) | $\mathrm{Q}_{\mathrm{g}}$ | - | 164 | - | nC |  |
| Gate-Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ | - | 6.9 | - | nC |  |
| Gate-Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ | - | 19.8 | - | nC |  |
| Turn-On Delay Time | $\mathrm{t}_{\mathrm{D}(\mathrm{ON})}$ | - | 9 | - | ns | $\begin{aligned} & V_{D D}=-10 \mathrm{~V}, V_{G E N}=-4.5 \mathrm{~V}, \\ & R_{G E N}=1 \Omega, I_{D}=-10 \mathrm{~A} \end{aligned}$ |
| Turn-On Rise Time | $\mathrm{t}_{\mathrm{R}}$ | - | 24 | - | ns |  |
| Turn-Off Delay Time | $\mathrm{t}_{\mathrm{D} \text { (OFF) }}$ | - | 69 | - | ns |  |
| Turn-Off Fall Time | $\mathrm{t}_{\mathrm{F}}$ | - | 107 | - | ns |  |
| Reverse Recovery Time | trR | - | 54 | - | ns | $\mathrm{IF}_{\mathrm{F}}=-10 \mathrm{~A}, \mathrm{di} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}$ |
| Reverse Recovery Charge | QRR | - | 55 | - | nC |  |

Notes: $\quad$ 5. Device mounted on FR-4 substrate PC board, $20 z$ copper, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2 oz copper, with 1inch square copper plate.
7. Thermal resistance from junction to soldering point (on the exposed drain pad).
8. $I_{A S}$ and $E_{A S}$ ratings are based on low frequency and duty cycles to keep $T_{J}=+25^{\circ} \mathrm{C}$.
9. Short duration pulse test used to minimize self-heating effect.
10. Guaranteed by design. Not subject to product testing.

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Figure 1. Typical Output Characteristic


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature


Figure 2. Typical Transfer Characteristic


Figure 4. Typical Transfer Characteristic


Figure 6. On-Resistance Variation with Junction Temperature

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Figure 7. On-Resistance Variation with Junction Temperature


Figure 9. Diode Forward Voltage vs. Current


Figure 11. Gate Charge


Figure 8. Gate Threshold Variation vs. Junction Temperature



Figure 12. SOA, Safe Operation Area

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Figure 13. Transient Thermal Resistance

## Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.


| PowerDI5060-8 |  |  |  |
| :---: | :---: | :---: | :---: |
| Dim | Min | Max | Typ |
| A | 0.90 | 1.10 | 1.00 |
| A1 | 0.00 | 0.05 | - |
| b | 0.33 | 0.51 | 0.41 |
| b2 | 0.200 | 0.350 | 0.273 |
| b3 | 0.40 | 0.80 | 0.60 |
| C | 0.230 | 0.330 | 0.277 |
| D | 5.15 BSC |  |  |
| D1 | 4.70 | 5.10 | 4.90 |
| D2 | 3.70 | 4.10 | 3.90 |
| D3 | 3.90 | 4.30 | 4.10 |
| E | 6.15 BSC |  |  |
| E1 | 5.60 | 6.00 | 5.80 |
| E2 | 3.28 | 3.68 | 3.48 |
| E3 | 3.99 | 4.39 | 4.19 |
| e | 1.27 BSC |  |  |
| G | 0.51 | 0.71 | 0.61 |
| K | 0.51 | - | - |
| L | 0.51 | 0.71 | 0.61 |
| L1 | 0.100 | 0.200 | 0.175 |
| M | 3.235 | 4.035 | 3.635 |
| M1 | 1.00 | 1.40 | 1.21 |
| © | $10^{\circ}$ | $12^{\circ}$ | $11^{\circ}$ |
| O1 | $6^{\circ}$ | $8^{\circ}$ | $7^{\circ}$ |
| All Dimensions in mm |  |  |  |
|  |  |  |  |

## Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.


| Dimensions | Value (in mm) |
| :---: | :---: |
| $\mathbf{C}$ | 1.270 |
| $\mathbf{G}$ | 0.660 |
| G1 | 0.820 |
| $\mathbf{X}$ | 0.610 |
| X1 | 4.100 |
| X2 | 0.755 |
| X3 | 4.420 |
| X4 | 5.610 |
| Y | 1.270 |
| Y1 | 0.600 |
| Y2 | 1.020 |
| Y3 | 0.295 |
| Y4 | 1.825 |
| Y5 | 3.810 |
| Y6 | 0.180 |
| Y7 | 6.610 |

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